

**Search Notes****Application/Control No.**

10/810,603

**Examiner**

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**Applicant(s)/Patent under  
Reexamination**

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**Art Unit**

2193

**SEARCHED**

Class	Subclass	Date	Examiner
708	320, 819	12/29/2010	MAI

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Data Bases Search (see search history printout(s))	12/29/2010	MAI